

Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10780579	ONOZAWA ET AL.
	Examiner Duong, Dieu Hien T	Art Unit 2821

SEARCHED

Class	Subclass	Date	Examiner
315	169.1,169.2,169.3,169.4	01/17/07	dd
345	60	01/17/07	dd

SEARCH NOTES

Search Notes	Date	Examiner
Please See East Search History	01/17/07	dd
Consulted with David Vu, primary 315	01/17/07	dd

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
315	169.1,169.2,169.3,169.4	01/17/07	dd
345	60	01/17/07	dd